

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 10/796,213 | Applicant(s)/Patent Under Reexamination HAYASHI, KUNIHICO | |
| | Examiner JENNIFER N. TO | Art Unit 2195 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| * | A | US-6,757,897 | 06-2004 | Shi et al. | 718/102 |
| * | B | US-5,774,718 | 06-1998 | Aoshima et al. | 718/100 |
| * | C | US-6,430,594 | 08-2002 | Akiyama et al. | 718/108 |
| * | D | US-7,207,045 | 04-2007 | Goiffon, Serge | 718/107 |
| * | E | US-7,039,012 | 05-2006 | Nakano et al. | 370/230 |
| * | F | US-2003/0037091 | 02-2003 | Nishimura et al. | 709/103 |
| * | G | US-2002/0174164 | 11-2002 | Hayashi, Kunihiko | 709/102 |
| * | H | US-5,628,013 | 05-1997 | Anderson et al. | 718/107 |
| * | I | US-5,812,844 | 09-1998 | Jones et al. | 718/104 |
| * | J | US-6,105,048 | 08-2000 | He, Xiaoyong | 718/100 |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.